Search Notes						

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/073,570	OKAWA ET AL.	
Examiner	Art Unit	
Afsar M. Qureshi	2616	

SEARCHED			
Class	Subclass	Date	Examiner
370	517	7/17/2007	AQ
	537		
	539		
	541		
	542		
	•		

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner

SEARCH N (INCLUDING SEAR)	IOTES CH STRATEGY	 ')
	DATE	EXMR
EAST, Text and class search	7/17/2007	AQ